# Old Company Name in Catalogs and Other Documents

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Renesas Electronics website: http://www.renesas.com

April 1<sup>st</sup>, 2010 Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (http://www.renesas.com)

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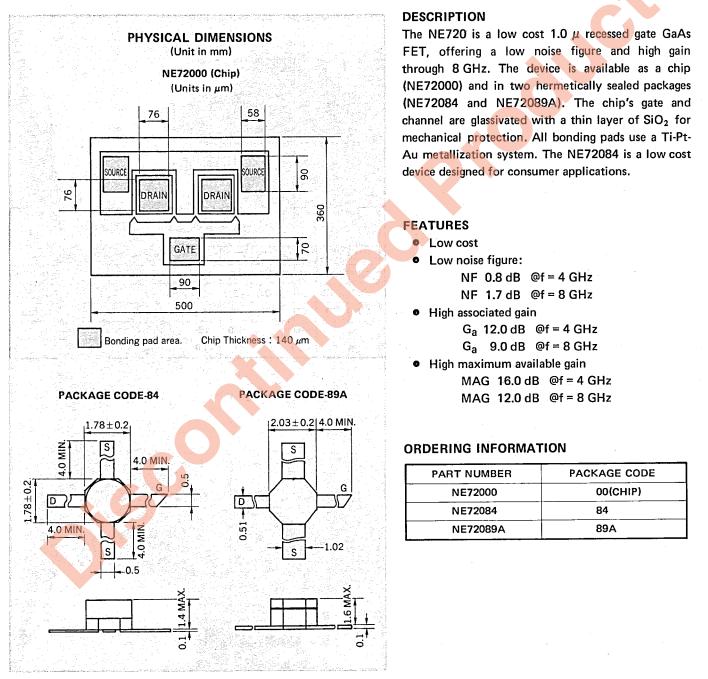
# DATA SHEET

# RENESAS

#### 1 A



# LOW COST GENERAL PURPOSE GaAs FET N-CHANNEL GaAs MES FET



#### PRECAUTION

Avoid high static voltages or electric fields so that this device would not suffer any damages due to those voltage of fields.

NEC cannot assume any responsibility for any circuits shown or represent that they are free from patent infringement.

### ABSOLUTE MAXIMUM RATINGS (T<sub>a</sub> = 25 $^{\circ}$ C)

4,9

Drain to Source Voltage	V <sub>DS</sub>	5.0	V	
Gate to Drain Voltage	V <sub>GDO</sub>	-6.0	V	
Gate to Source Voltage	V <sub>GSO</sub>	-6.0	V	
Drain Current	IDS	150	mA	
<b>Total Power Dissipation</b>	PT	500 <sup>*1,*3</sup>	mW	(NE72000)
		300*2	mW	(NE72084)
		300*2	mŴ	(NE72089A)
Channel Temperature	T <sub>ch</sub>	175	°C	
Storage Temperature	T <sub>stg</sub>	-65 to +175	°C	(NE72089A)

\*1  $T_a = 90 \degree C$ \*2  $T_a = 55 \degree C$ \*3  $R_{th}$  (channel to case) for chips mounted on a copper heat sink.

## ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25 $^{\circ}$ C)

PART NUMBER		NE72000		NE72084		NE72089A						
PACKAGE CODE			CHIP			84			89A		UNIT	TEST CONDITIONS
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	-	
Saturated Drain Current	IDSS*4	30	60	150	30	60	150	30	60	150	mA	V <sub>DS</sub> = 3 V, V <sub>GS</sub> = 0
Pinch-off Voltage	Vp	-0.8	-2.0	-6.0	-0.8	-1.5	-4	-0.8	-2.0	-6.0	v	V <sub>DS</sub> = 3 V, I <sub>DS</sub> = 0.1 mA
Transconductance	9 <sub>m</sub>	20	40	100	20	40	60	20	40	100	mS	V <sub>DS</sub> = 3 V, I <sub>DS</sub> = 10 mA
Gate to Source Leakage Current	IGSO		1.0	10			10		1.0	10	μA	VGS =5 V
Thermal Resistance	R <sub>th</sub>			170*3			400			400	°C/W	channel to case

4

\*4 IDSS rank for NE72084 is specified as follows.

K rank ;	I <sub>DSS</sub> 30 to 150 mA
L rank ;	IDSS 90 to 150 mA
M rank ;	IDSS 55 to 100 mA
N rank ;	I <sub>DSS</sub> 30 to 65 mA

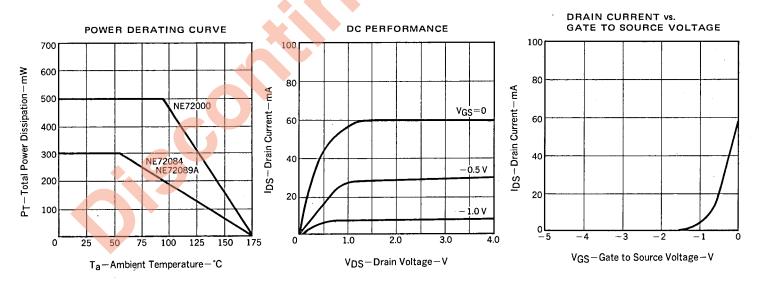
PART NUMBER		NE72000		NE72084		NE72089A							
PACKAGE CODE			CHIP			84			89A		UNIT	TEST CONDITIONS	
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.			
Maximum Frequency of Oscillation	f <sub>max.</sub>		60			60			60		GHz	V <sub>DS</sub> = 3 V, I <sub>D</sub>	<sub>S</sub> = 30 mA
Maximum Available Gain* <sup>5</sup>						17.5					dB		f = 2 GHz
			16.5			15.0			16.0		dB	V <sub>DS</sub> = 3 V I <sub>DS</sub> = 30 mA	f = 4 GHz
	MAG	,	11.5			12.0			11.0		dB		f = 8 GHz
						8.0					dB		f = 12 GHz
· · · · · ·	NFopt					0.6					dB	V <sub>DS</sub> = 3 V I <sub>DS</sub> = 10 mA	f = 2 GHz
Optimum Noise Figure			1.0	1.4		0.8	1.4		1.0	1.4	dB		f = 4 GHz
			1.7			2.0			1.7		dB		f = 8 GHz
						15.0					dB		f = 2 GHz
Associated Gain at Optimum Noise Figure	Ga		11.0			12.0			11.0		dB	V <sub>DS</sub> = 3 V I <sub>DS</sub> = 10 mA	f = 4 GHz
Optimizin Holdo Figuro			9.0			8.5			9.0		dB		f = 8 GHz
Output Power at 1 dB Gain Compression Point	PO(1 dB)		15.0			15.0			15.0		dBm	V <sub>DS</sub> = 4 V I <sub>DS</sub> = 30 mA	f = 4 GHz

### PERFORMANCE SPECIFICATIONS (T<sub>a</sub> = 25 $^{\circ}$ C)

<sup>25</sup> Gain Calculations : MAG = 
$$\frac{|S_{21}|}{|S_{12}|}$$
 (K ±  $\sqrt{K^2 - 1}$ ), K =  $\frac{1 + |\Delta|^2 - |S_{11}|^2 - |S_{22}|^2}{2|S_{12}||S_{21}|}$ ,  $\Delta = S_{11}S_{22} - S_{21}S_{12}$ 

 $MSG = \frac{|S_{21}|}{|S_{12}|}$ 

#### **DEVICE CHARACTERISTICS**



20

12

8

0

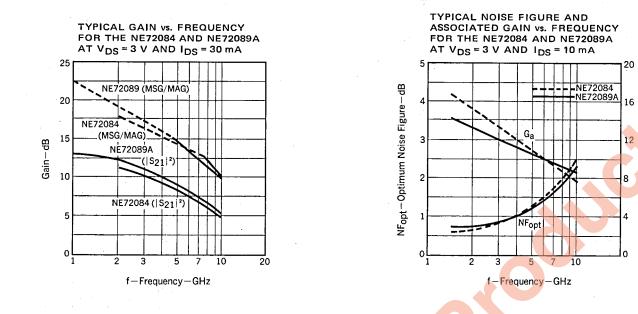
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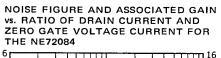
B

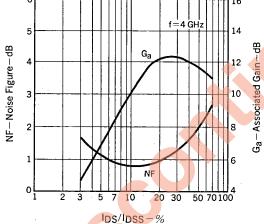
Associated Gain

1 ප්

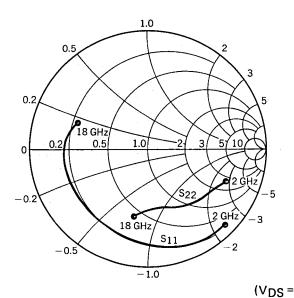
#### TYPICAL CHARACTERISTICS ( $T_a = 25$ °C)

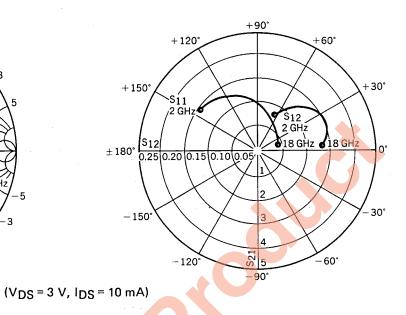






#### **NE72000 S-PARAMETERS**





#### S-MAGN AND ANGLES

(V<sub>DS</sub> = 3 V, I<sub>DS</sub> = 10 mA)

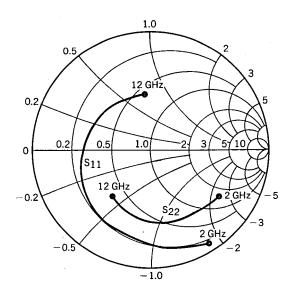
frequency (MHz)	S <sub>11</sub>	S <sub>21</sub>	\$ <sub>12</sub>	\$ <sub>22</sub>
2000	0.9144	2.95 144	0.08 64	0.71 –22
3000	0.90 —63	2.81 132	0.11 53	0.6827
4000	0.83 —81	2.47 113	0.12 44	0.62 –35
5000	0.78 –96	2.27 105	0.14 36	0.5843
6000	0.75 –108	2.08 97	0.15 32	0.56 –52
7000	0.70 –119	1.83 87	0.15 26	0.55 —58
8000	0.67 –130	1.65 79	0.15 19	0.55 –63
9000	. 0.66 —140 🌰	1.49 72	0.15 18	0.5 <u>6</u> –65
10000	0.64	1.37 64	0.15 15	0.56 –67
11000	0.64 –158	1.24 59	0.14 14	0.54 –66
12000	0.67 –165	1.18 54	0.14 13	0.54 –67
13000	0.69 –168	1.11 49	0.14 11	0.5174
14000	0.69 -175	1.11 44	0.14 12	0.5480
15000	0.65 -178	0.98 38	0.13 9	0.55 –86
16000	0.66 174	1.02 33	0.14 9	0.53 –90
17000	0.63 164	0.96 26	0.13 8	0.56 -95
18000	0.64 160	0.86 21	0.13 9	0.50 –97
$(V_{DS} = 3 V, I_{DS} = 30 mA)$				
frequency (MHz)				
2000	0.90 -49	3.61 143	0.07 62	0.65 –24
3000	0.8970	3.39 130	0.10 52	0.61 –28
4000	0.8388	2.91 117	0.11 44	0.55 –36
5000	0.78 -103	2.63 104	0.12 36	0.51 -44
6000	0.75 –116	2.37 97	0.13 33	0.4953
7000	0.70 –126	2.08 87	0.13 27	0.4959
8000	0.68 –137	1.87 79	0.13 22	0.4964
9000	0.67 –148	1.67 73	0.13 21	0.5167
10000	0.65 –158	1.53 65	0.12 19	0.51 –68
11000	0.65 –164	1.37 60	0.12 18	0.49 –67
12000	0.70 -171	1.32 55	0.12 18	0.47 –68
13000	0.72 –174	1.23 51	0.12 17	0.47 –75
14000	0.74 –180	1.22 46	0.13 20	0.49 –81
15000	0.67 177	1.09 40	0.12 17	0.50 –87
16000	0.69 169	1.12 36	0.12 18	0.50 -90
17000	0.66 158	1.05 28	0.13 18	0.52 –96
18000	0.67 156	0.94 24	0.12 20	0.56 –98
-				

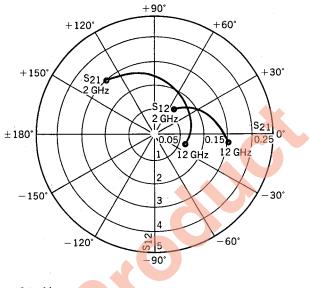
5

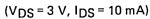
NE720

NEC ELECTRON DEVICE

#### NE72084 S-PARAMETERS







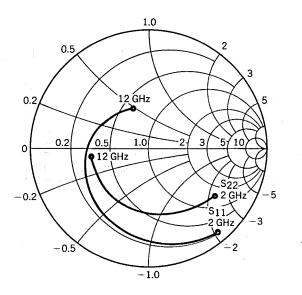
### S-MAGN AND ANGLES

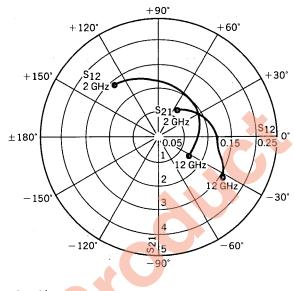
(V<sub>DS</sub> = 3 V, I<sub>DS</sub> = 10 mA)

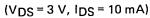
				0
frequency (MHz)	• S <sub>11</sub>	S <sub>21</sub>	S <sub>12</sub>	S <sub>22</sub>
2000	0.91 –60	3.02 131	0.07 54	0.70 –36
3000	0.8281	2.65 108	0.09 39	0.66 -49
4000	0.76 102	2.36 92	0.11 30	0.64 –63
5000	0.72 —122 🍐	2.17 76	0.12 21	0.62 –73
6000	0.66 —139	1.97 58	0.12 13	0.61 –80
7000	0.61 –156	1.81 45	0.12 9	0.61 –90
8000	0.56 —176	1.69 34	0.12 5	0.60 –97
9000	0.53 167	1.62 18	0.13 2	0.59 105
10000	0.50 142	1.59 4	0.13 0	0.57 –111
11000	0.48 114	1.499	0.14 –5	0.55 –116
12000	0.48 94	1.37 –20	0.15 –9	0.50 –128
(V <sub>DS</sub> = 3 V, I <sub>DS</sub> = 30 mA) frequency (MHz)	G			
2000	0.88 –65	4.04 125	0.06 55	0.61 —35
3000	0.78 –94	3.58 101	0.08 39	0.55 -51
4000	0.69 –121	3.11 81	0.09 30	0.50 –66
5000	0.62 –148	2.74 62	0.10 23	0.45 —80
6000	0.59 –173	2.46 45	0.10 19	0.44 –93
7000	0.57 166	2.17 29	0.11 15	0.42
8000	0.56 148	2.01 14	0.11 12	0.42 –122
9000	0.56 128	1.88 —0	0.12 9	0.42 –138
10000	0.57 107	1.78 —15	0.14 6	0.43 –152
11000	0.58 87	1.64 —33	0.15 —6	0.43 –174
12000	0.60 72	1.47 –46	0.16 –13	0.41 166

**NE720** 

#### NE72089A S-PARAMETERS





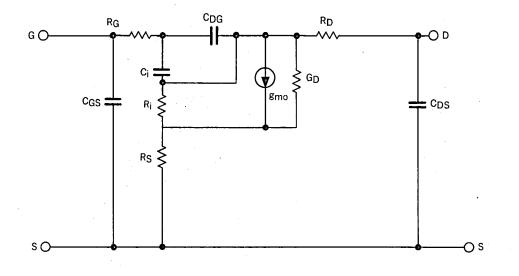


#### S-MAGN AND ANGLES

 $(V_{DS} = 3 V, I_{DS} = 10 mA)$ 

								· · · ·	
frequency (MHz)	S <sub>11</sub>		S2	1		S	12	S	22
2000	0.92	-52	2.94	130		0.07	54	0.68	35
3000	0.84	75	2.62	108		0.09	38	0.63	51
4000	0.76	-95	2.34	90		0.11	26	0.59	66
5000	0.71	-113 🔺 💧	2.18	72		0.12	16	0.58	79
6000	0.65	–131	2.02	56		0.13	7	0.56	93
7000	0.59	-146	1.86	41		0.13	1	0.54	-105
8000	0.55	-160	1.76	26		0.13	7	0.54	116
9000	0.49	-177	1.68	13		0.13	-12	0.53	-129
10000	0.44 🔺	165	1.66	-1		0.14	-17	0.53	-139
11000	0.39	140	1.63	-19		0.15	26	0.52	-154
12000	0.37	112	1.55	-34		0.16	-33	0.51	-170
(V <sub>DS</sub> = 3 V, I <sub>DS</sub> = 30 mA)				x					
frequency (MHz)									
2000	0.89	58	3.76	127		0.06	55	0.60	-35
3000	0.79	82	3.27	105	· •	80.0	40	0.56	50
4000	0.72	-103	2.88	86		0.09	31	0.53	64
5000	0.66	-121	2.61	69		0.10	22	0.51	75
6000	0.60	-139	2.38	54		0.11	16	0.50	-86
7000	0.55	-155	2.18	38		0.11	10	0.50	97
8000	0.50	–170	2.04	24		0.12	6	0.50	108
9000	0.44	172	1.93	11		0.12	2	0.49	118
10000	0.40	152	1.89	-3		0.14	2	0.50	-126
11000	0.36	126	1.83	20		0.15	11	0.49	-138
12000	0.35	99	1.72	-36		0.16	18	0.48	151

#### **NE72000 EQUIVALENT CIRCUITS**



COMPONENT	VALU	JE_	
RG	0.57	Ω	
Ci	0.15	рF	
Ri	2.00	Ω	
RS	2.00	Ω	
CDG	0.03	рF	
RD	2.00	Ω	
CDS	0.015	pF	
g <sub>mo</sub> (mS)	40.0	mS	
GD (mS)	2.0	mS	<b>.</b>
CGS	0.55	pF	

## NE72084 TYPICAL NOISE PARAMETERS (V<sub>DS</sub> = 3V, $I_D$ = 10 mA)

Freq. NF <sub>opt</sub>		Ga	Γ <sub>opt</sub>	Rn/50	
(GHz)	(dB)	(dB)	MAG.	ANG. (°)	(Ω)
1.0	0.60	17.7	0.81	18	0.53
2.0	0.69	14.8	0.74	43	0.50
3.0	0.78	13.0	0.70	60	0.45
4.0	0.85	11.8	0.66	91	0.42
5.0	1.10	10.7	0.61	111	0.39
6.0	1.40	9.9	0.56	131	0.37
7.0	1.62	9.2	0.52	151	0.34
8.0	2.00	8.5	0.49	170	0.32
9.0	2.25	8.0	0.47	-172	0.27
10.0	2.48	7.5	_0.47	153	0.19
11.0	2.70	6.9	0.47	-127	0.13 .
12.0	2.90	6.4	0.45	-106	0.10
13.0	3.11	5.8	0.44	-83	0.09
14.0	3.30	5.4	0.44	-63	0.08
15.0	3.42	5.0	0.45	-44	0.08
16.0	.3.60	4.6	0.46	-27	0.07
17.0	3.72	4.2	0.48	-12	0.07
18.0	3.92	3.8	0.49	-1	0.07

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#### CHIP HANDLING

#### **DIE ATTACHEMENT**

Die attach can be accomplished with a Au-Sn (300  $\pm$  10  $^{\circ}$ C) preforms in a forming gas environment. Epoxy die attach is not recommended.

#### BONDING

Gate and drain bonding wires should be minimum length, semi-hard gold wire (3-8% elongation) 20 microns or less in diameter. Bonding should be performed with a wedge tip that has a taper of approximately 15%. Die attach and bonding time should be kept to a minimum. As a general rule, the bonding operation should be kept within a 280  $^{\circ}$ C - 5 minute curve. If longer periods are required, the temperature should be lowered.

#### PRECAUTIONS

The user must operate in a clean, dry environment. The chip channel is glassivated for mechanical protection only and does not preclude the necessity of a clean environment.

The bonding equipment should be periodically checked for sources of surge voltage and should be properly grounded at all times. In fact, all test and handling equipment should be grounded to minimize the possibilities of static discharge.

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